

**Search Notes**

Application/Control No.

10/811,388

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

TAKAHASHI ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	129, first 500 patents	07/01/05	NKV
330	279, first 300 patents	07/10/05	NKV
330	285, first 400 patents	07/01/05	NKV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		11/18/05	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	11/18/05	NKV
IEEE	11/21/05	NKV